

Search Notes

Application/Control No.

10/607,612

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

PUPPO ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	710	7/11/2005	BT
438	713	7/11/2005	BT
438	719	7/11/2005	BT
438	723	7/11/2005	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search inventor's name and keywords using USPAT, US-PGPUB, JPO, EPO, DERWENT databases	7/11/2005	BT